

### MTP52N06VL-VB Datasheet N-Channel 60 V (D-S) MOSFET

PRODUCT	SUMMARY	
V <sub>DS</sub> (V)	R <sub>DS(on)</sub> (Ω)	I <sub>D</sub> (A) <sup>a</sup>
60	0.024 at V <sub>GS</sub> = 10 V	50
00	0.028 at V <sub>GS</sub> = 4.5 V	40

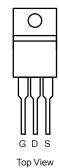
#### **FEATURES**

- Halogen-free According to IEC 61249-2-21 Definition
- Surface Mount
- Available in Tape and Reel
- Dynamic dV/dt Rating
- Logic-Level Gate Drive
- Fast Switching
- Compliant to RoHS Directive 2002/95/EC

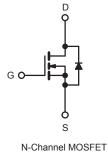


RoHS'

COMPLIANT



**TO-220AB** 



ABSOLUTE MAXIMUM RATINGS ( $T_C$	= 25 °C, unl	ess otherwis	se noted)		
PARAMETER			SYMBOL	LIMIT	UNIT
Drain-Source Voltage			V <sub>DS</sub>	60	V
Gate-Source Voltage			V <sub>GS</sub>	± 20	v
Continuous Drain Current <sup>f</sup>	V <sub>GS</sub> at 10 V	T <sub>C</sub> = 25 °C	I_	50	
Continuous Drain Current	VGS at 10 V	T <sub>C</sub> = 100 °C	I <sub>D</sub>	36	А
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	200	
Linear Derating Factor				1.0	W/°C
Linear Derating Factor (PCB Mount) <sup>e</sup>				0.025	W/ C
Single Pulse Avalanche Energy <sup>b</sup>			E <sub>AS</sub>	400	mJ
Maximum Power Dissipation	T <sub>C</sub> = 25 °C		р	150	W
Maximum Power Dissipation (PCB Mount)e	T <sub>A</sub> = 25 °C		P <sub>D</sub>	3.7	vv
Peak Diode Recovery dV/dt <sup>c</sup>			dV/dt	4.5	V/ns
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 175	°C
Soldering Recommendations (Peak Temperature) <sup>d</sup>	for	10 s		300 <sup>d</sup>	

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b.  $V_{DD} = 25 \text{ V}$ , starting  $T_J = 25 \text{ °C}$ ,  $L = 179 \text{ }\mu\text{H}$ ,  $R_g = 25 \Omega$ ,  $I_{AS} = 51 \text{ A}$  (see fig. 12). c.  $I_{SD} \le 51 \text{ A}$ , dl/dt  $\le 250 \text{ A/}\mu\text{s}$ ,  $V_{DD} \le V_{DS}$ ,  $T_J \le 175 \text{ °C}$ .

e. When mounted on 1" square PCB (FR-4 or G-10 material).

f. Current limited by the package, (die current = 51 A).

d. 1.6 mm from case.

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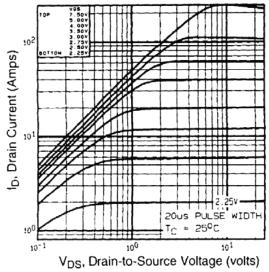


THERMAL RESISTANCE RATI	NGS	1				r		
PARAMETER	SYMBOL	ТҮР		MAX.			UNIT	
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-		62				
Maximum Junction-to-Ambient (PCB Mount) <sup>a</sup>	R <sub>thJA</sub>	-		40		°C/W		
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-		1.0				
ote . When mounted on 1" square PCB (FR-4	or G-10 material	). 1						
SPECIFICATIONS (T_J = 25 °C, $\upsilon$	inless otherw	ise noted)						
PARAMETER	SYMBOL	TES		IONS	MIN.	TYP.	MAX.	UNI
Static								
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub>	= 0, I <sub>D</sub> = 25	50 μA	60	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Referenc	e to 25 °C,	I <sub>D</sub> = 1 mA	-	0.070	-	V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =	: V <sub>GS</sub> , I <sub>D</sub> = 2	250 μA	1.0	-	2.5	
Gate-Source Leakage	I <sub>GSS</sub>		V <sub>GS</sub> = ± 10	V	-	-	± 100	nA
		$V_{DS} = 60 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$		-	-	25	μA	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS} = 48 V_{c}$	48 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 150 °C			-		250
		V <sub>GS</sub> = 10 V		= 21 A <sup>b</sup>	-	0.024	-	
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 4.5 V	_	= 15 A <sup>b</sup>	-	0.028	-	Ω
Forward Transconductance	g <sub>fs</sub>		= 25 V, I <sub>D</sub> =		23	-	-	S
Dynamic	0.0				I			1
Input Capacitance	C <sub>iss</sub>				-	190		
Output Capacitance	C <sub>oss</sub>	-	$V_{GS} = 0 V,$ $V_{DS} = 25 V$		_	920	_	pF
Reverse Transfer Capacitance	C <sub>rss</sub>		0 MHz, see		-	170	-	1
Total Gate Charge	Qg				_	_	66	
Gate-Source Charge	Q <sub>gs</sub>	V <sub>GS</sub> = 5.0 V		51 A, V <sub>DS</sub> = 48 V,	_	_	12	nC
Gate-Drain Charge	Q <sub>gd</sub>		see fig	g. 6 and 13 <sup>b</sup>	_	_	43	
Turn-On Delay Time	t <sub>d(on)</sub>				-	17	-	
Rise Time	t <sub>r</sub>	$V_{DD}$ = 30 V, I <sub>D</sub> = 51 A, R <sub>g</sub> = 4.6 Ω, R <sub>D</sub> = 0.56 Ω, see fig. 10 <sup>b</sup>			230		- ns	
Turn-Off Delay Time	t <sub>d(off)</sub>			-	200	_		
Fall Time	t <sub>f</sub>			-	110	_		
Internal Drain Inductance	L <sub>D</sub>	Between lead, 6 mm (0.25") from		-	4.5	-		
Internal Source Inductance	L <sub>S</sub>	package and die contact			-	7.5	-	nH
Drain-Source Body Diode Characteristic	cs	I				<u> </u>		I
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET sym showing the			-	-	50 <sup>c</sup>	
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>	integral revers p - n junction			-	-	200	A
Body Diode Voltage	V <sub>SD</sub>	T <sub>J</sub> = 25 °C	, I <sub>S</sub> = 51 A,	V <sub>GS</sub> = 0 V <sup>b</sup>	-	-	2.5	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	<b>T</b> 07.00 ·		u 400 t k	-	130	180	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	T <sub>J</sub> = 25 °C, I <sub>F</sub>	= 51 A, dl/	dt = 100 A/µs <sup>b</sup>	-	0.84	1.3	μC
Forward Turn-On Time	t <sub>on</sub>	Intrinsic tu	rn-on time	is negligible (turn	-on is dor	ninated b	vlaand	<u>.</u>

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
b. Pulse width ≤ 300 µs; duty cycle ≤ 2 %.
c. Current limited by the package, (Die Current = 51 A).



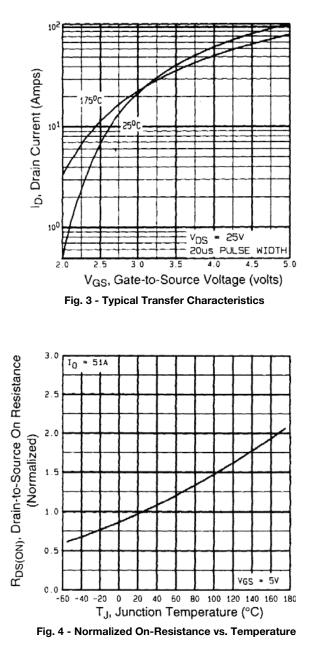


### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)





Fig. 2 - Typical Output Characteristics, T<sub>C</sub> = 150 °C





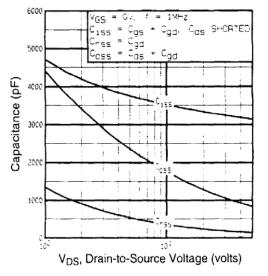


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

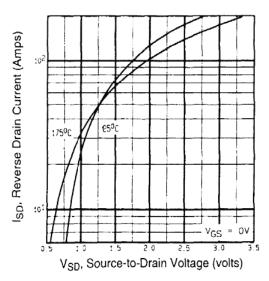
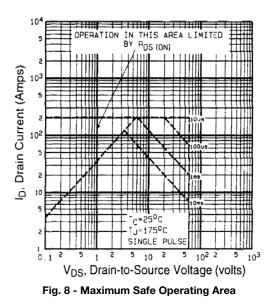


Fig. 7 - Typical Source-Drain Diode Forward Voltage



Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage





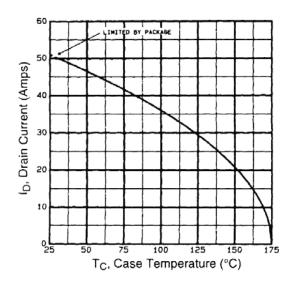


Fig. 9 - Maximum Drain Current vs. Case Temperature

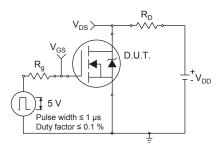


Fig. 10a - Switching Time Test Circuit

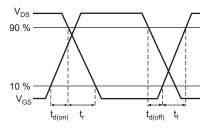


Fig. 10b - Switching Time Waveforms

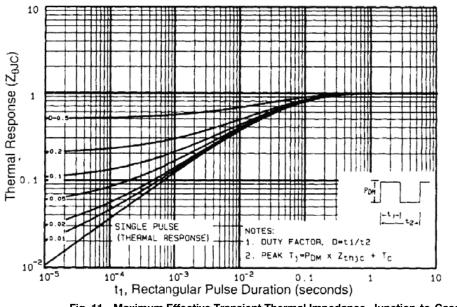


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



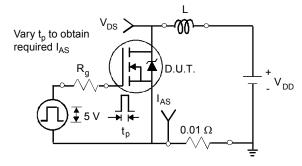


Fig. 12a - Unclamped Inductive Test Circuit

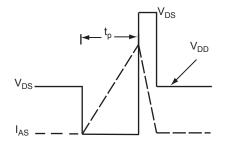


Fig. 12b - Unclamped Inductive Waveforms



Fig. 12c - Maximum Avalanche Energy vs. Drain Current

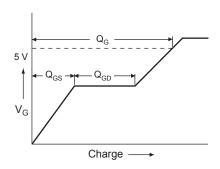


Fig. 13a - Basic Gate Charge Waveform

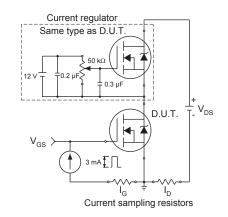
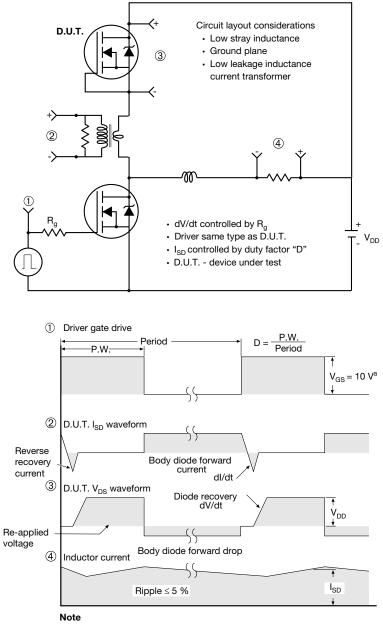


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit

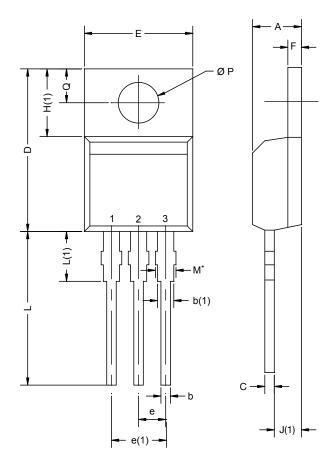


a.  $V_{GS}$  = 5 V for logic level devices

Fig. 14 - For N-Channel



### **TO-220AB**



IN.           25           69           20           36           .85           .04	MAX.           4.65           1.01           1.73           0.61           15.49           10.51           2.67	MIN.           0.167           0.027           0.047           0.014           0.585           0.395	MAX. 0.183 0.040 0.068 0.024 0.610 0.414
69 20 36 .85 .04	1.01 1.73 0.61 15.49 10.51	0.027 0.047 0.014 0.585 0.395	0.040 0.068 0.024 0.610
20 36 .85 .04	1.73 0.61 15.49 10.51	0.047 0.014 0.585 0.395	0.068 0.024 0.610
36 .85 .04	0.61 15.49 10.51	0.014 0.585 0.395	0.024
.85 .04	15.49 10.51	0.585 0.395	0.610
.04	10.51	0.395	
-			0.414
41	2.67	0.005	
		0.095	0.105
88	5.28	0.192	0.208
14	1.40	0.045	0.055
09	6.48	0.240	0.255
41	2.92	0.095	0.115
.35	14.02	0.526	0.552
32	3.82	0.131	0.150
54	3.94	0.139	0.155
60	3.00	0.102	0.118
í	32 54 60	54         3.94           60         3.00	54 3.94 0.139

### Notes

\* M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM



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